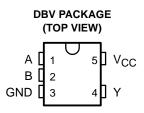
- Operating Range 2-V to 5.5-V V_{CC}
- EPIC[™] (Enhanced-Performance Implanted CMOS) Process
- High Latch-Up Immunity Exceeds 250 mA Per JESD 17
- Packaged in Plastic Small-Outline Transistor Package



description

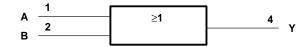
The SN74AHC1G32 is a single 2-input positive-OR gate. The device performs the Boolean function Y = A + B or $Y = \overline{A \bullet B}$ in positive logic.

The SN74AHC1G32 is characterized for operation from -40°C to 85°C.

FUNCTION TABLE

INP	UTS	OUTPUT
Α	В	Υ
Н	Х	Н
Х	Н	Н
L	L	L

logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)





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absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage range, V _{CC}	0.5 V to 7 V
Input voltage range, V _I (see Note 1)	0.5 V to 7 V
Output voltage range, V _O (see Note 1)	0.5 V to V _{CC} + 0.5 V
Input clamp current, I_{IK} ($V_I < 0$)	–20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	±20 mA
Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$	±25 mA
Continuous current through V _{CC} or GND	±50 mA
Package thermal impedance, θ_{JA} (see Note 2)	347°C/W
Storage temperature range, T _{stq}	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions (see Note 3)

			MIN	MAX	UNIT
VCC	Supply voltage		2	5.5	V
	V _{CC} = 2 V		1.5		
V_{IH}	High-level input voltage	V _{CC} = 3 V	2.1		V
		V _{CC} = 5.5 V	3.85		
		V _{CC} = 2 V		0.5	
V_{IL}	Low-level input voltage	V _{CC} = 3 V		0.9	V
	V _{CC} = 5.5 V		1.65		
٧ _I	Input voltage		0	5.5	V
VO	Output voltage		0	VCC	V
	V _{CC} = 2 V	V _{CC} = 2 V		-50	μΑ
IOH	High-level output current	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		-4	mA
		$V_{CC} = 5 V \pm 0.5 V$		-8	IIIA
		V _{CC} = 2 V		50	μΑ
IOL	Low-level output current			4	mA
	$V_{CC} = 5 V \pm 0.5 V$			8	IIIA
A+/A>.	Input transition rise or fall rate $ \frac{V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}}{V_{CC} = 5 \text{ V} \pm 0.5 \text{ V}} $			100	ns/V
Δt/Δv				20	115/V
TA	Operating free-air temperature		-40	85	°C

NOTE 3: Unused inputs must be held high or low to prevent them from floating.



NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

^{2.} The package thermal impedance is calculated in accordance with JESD 51.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	Voc	T _A = 25°C			MIN	MAY	UNIT	
PARAMETER	TEST CONDITIONS	vcc	MIN	TYP	MAX	IVIIIV	0.1 0.1 0.1 0.44 0.44 ±1	UNIT	
		2 V	1.9	2		1.9			
	I _{OH} = -50 μA	3 V	2.9	3		2.9			
V _{OH}		4.5 V	4.4	4.5		4.4		V	
	I _{OH} = -4 mA	3 V	2.58			2.48			
	I _{OH} = -8 mA	4.5 V	3.94			3.8			
	I _{OL} = 50 μA				0.1		0.1	V	
					0.1		0.1		
VOL					0.1		0.1		
	I _{OL} = 4 mA	3 V			0.36		0.44		
	I _{OL} = 8 mA	4.5 V			0.36		0.44		
I _I A or B inputs	$V_I = V_{CC}$ or GND	5.5 V			±0.1		±1	μΑ	
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			1		10	μΑ	
Ci	V _I = V _{CC} or GND	5 V		2	10		10	pF	

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	TO LOAD		T _A = 25°C			MIN	MAX	UNIT		
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	INITIA	IVIAX	UNII		
^t PLH	A or B				C: 45 pF		5.5	7.9	1	9.5	20
^t PHL	AUIB	ī	Y $C_L = 15 \text{ pF}$		5.5	7.9	1	9.5	ns		
^t PLH	A or B	V	C. 50 pF		8	11.4	1	13	ns		
^t PHL		ī	C _L = 50 pF		8	11.4	1	13	115		

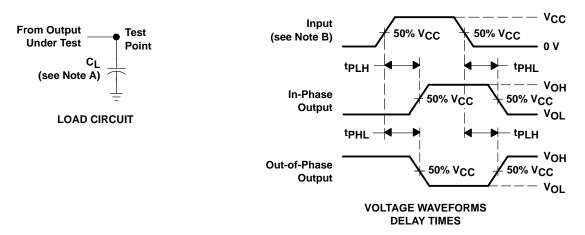
switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	LOAD	T,	4 = 25°C	;	MIN	MAX	UNIT									
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	IVIIIA	IVIAA	UNIT									
tpLH	A or B	V	V C. – 15 pE		3.8	5.5	1	6.5	ns									
tPHL	7010	1	, '		ľ	<u>'</u>	<u>'</u>	'	'	I I	C _L = 15 pF	CL = 15 pr		3.8	5.5	1	6.5	115
t _{PLH}	A or D	A or B	V	Y C _I = 50 pF		5.3	7.5	1	8.5	200								
^t PHL	AUIB	1	OL = 50 pr		5.3	7.5	1	8.5	ns									

operating characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

	PARAMETER		ONDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance	No load,	f = 1 MHz	14	pF

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50~\Omega$, $t_f = 3~ns$, $t_f = 3~ns$.
- C. The output is measured with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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